

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/829,418	LEE ET AL.
Examiner	Art Unit	
Yevgeny Valenrod	1621	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
STIC search, see transcript	7/10/2006	YV
STN structure/text search, see transcript	7/12/2006	YV
Inventor search	7/13/2006	YV
564/34, 35, 38, 44, 45 +text search, See transcript	7/13/2006	YV

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner